Notice	of References	Cited
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Application/Control No.	Applicant(s)/Pater	nt Under
10/598,422	Reexamination DENG ET AL.	
Examiner	Art Unit	
KUO WOO	4133	Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,144,848 A	11-2000	Walsh et al.	455/419
*	В	US-2002/0087996 A1	07-2002	Bi et al.	725/89
*	С	US-2003/0034898 A1	02-2003	Shamoon et al.	340/825.72
*	D	US-2005/0076242 A1	04-2005	Breuer, Rolf	713/201
*	Е	US-7,205,892 B2	04-2007	Luebke et al.	340/539.26
*	F	US-2004/0249925 A1	12-2004	Jeon et al.	709/223
	G	US-		-	
	Н	US-			
		US-			
	J	US-			
	к	US-			
	٦	US-			
	м	US-			

## FOREIGN PATENT DOCUMENTS

	FOREIGN FATENT DOCUMENTS					
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	т					

## NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	×	

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